


<b>Search Notes</b>  	<b>Application/Control No.</b>  10775957	<b>Applicant(s)/Patent Under Reexamination</b>  BHUSHAN ET AL.
	<b>Examiner</b>  Hanh Nguyen	<b>Art Unit</b>  2416

SEARCHED			
Class	Subclass	Date	Examiner
455	452.1	7/7/09	hn
	450		
	452.2		
	33.4		
	56.1		
	266		
	512		
455	464		
370	329		
	335		
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	341		
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	432		
	320		
370	318	7/7/09	hn

SEARCH NOTES		
Search Notes	Date	Examiner
east search, see search history	7/7/09	hn

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	see interference search history printout	7/7/09	hn

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